High Bandwidth,Analog/Video Optocouplers

## Data Sheet

## Description

The HCPL-4562 and HCNW4562 optocouplers provide wide bandwidth isolation for analog signals. They are ideal for video isolation when combined with their application circuit (Figure 4). High linearity and low phase shift are achieved through an AlGaAs LED combined with a high speed detector. These single channel optocouplers are available in 8-Pin DIP and Widebody package configurations.

## Functional Diagram



## Features

- Wide bandw idth ${ }^{[1]}$ :

17 M Hz (HCPL-4562)
9 MHz (HCNW 4562)

- High voltage gain ${ }^{[1]}$ : 2.0 (HCPL-4562) 3.0 (HCN W 4562)
- Low $\mathrm{G}_{\mathrm{v}}$ temperature coefficient: $-0.3 \% /{ }^{\circ} \mathrm{C}$
- Highly linear at low drive currents
- High-speed AIGaAs emitter
- Safety approval:

UL Recognized

- 3750 V rms for 1 minute ( 5000 V rms for 1 minute for HCPL-4562\#020 and HCNW 4562) per UL 1577
CSA Approved
IEC/ EN/ DIN EN 60747-5-2 Approved
- $\mathrm{V}_{\text {IORM }}=1414 \mathrm{~V}_{\text {peak }}$ for HCNW 4562
- Available in 8-pin DIP and widebody packages


## Applications

- Video isolation for the following standards/ formats: NTSC, PAL, SECAM, S-VHS, ANALOG RGB
- Low drive current feedback element in switching power supplies, e.g., for ISDN netw orks
- A/ D converter signal isolation
- Analog signal ground isolation
- High voltage insulation

[^0]| Selection Guide |  |
| :--- | :--- |
| Single Channel Packages |  |
| 8-Pin DIP | Widebody |
| (300 Mil) | (400 M il) |
| HCPL-4562 | HCNW4562 |

## Ordering Information

HCPL-4562 is UL Recognized with 3750 Vrms for 1 minute per UL1577 unless otherwise specified. HCNW4562 is UL Recognized with 5000 Vrms for 1 minute per UL1577.

| Part Number | Option |  | Package | Surface <br> Mount | Gull <br> Wing | Tape \& Reel | UL 5000 Vrms/ 1 M inute rating | IEC/ EN/ DIN EN 60747-5-2 | Quantity |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  | RoHS <br> Compliant | non RoHS <br> Compliant |  |  |  |  |  |  |  |
| HCPL-4562 | -000E | no option | 300 mil DIP-8 |  |  |  |  |  | 50 per tube |
|  | -300E | \#300 |  | X | X |  |  |  | 50 per tube |
|  | -500E | \#500 |  | X | X | X |  |  | 1000 per reel |
|  | -020E | \#020 |  |  |  |  | X |  | 50 per tube |
|  | -320E | \#320 |  | X | X |  | X |  | 50 per tube |
|  | -520E | \#520 |  | X | X | X | X |  | 1000 per reel |
|  | -060E | \#060 |  |  |  |  |  | $X^{[1]}$ | 50 per tube |
| HCNW 4562 | -000E | no option | 400 mil <br> Widebody DIP-8 |  |  |  | X | $X^{[2]}$ | 42 per tube |
|  | -300E | \#300 |  | X | X |  | X | $X^{[2]}$ | 42 per tube |
|  | -500E | \#500 |  | X | X | X | X | $X^{[2]}$ | 750 per reel |

## Notes:

1. IEC/ EN/ DIN EN 60747-5-2 $\mathrm{V}_{\text {IORM }}=630 \mathrm{~V}_{\text {peak }}$ Safety Approval.
2. IEC/ EN/ DIN EN 60747-5-2 $\mathrm{V}_{\text {IORM }}=1414 \mathrm{~V}_{\text {peak }}$ Safety Approval.

To order, choose a part number from the part number column and combine with the desired option from the option column to form an order entry.

Example 1:
HCPL-4562-520E to order product of Gull Wing Surface Mount package in Tape and Reel packaging with UL 5000 Vrms/ 1 minute rating and RoHS compliant.

Example 2:
HCNW4562 to order product of 8-Pin Widebody DIP package in Tube packaging with IEC/EN/DIN EN 60747-5-2 $\mathrm{V}_{\text {IORM }}=1414 \mathrm{~V}_{\text {peak }}$ Safety Approval and UL $5000 \mathrm{Vrms} / 1$ minute rating and non RoHS compliant.

Option datasheets are available. Contact your Avago sales representative or authorized distributor for information.

Remarks: The notation '\#XXX' is used for existing products, while (new) products launched since July 15,2001 and RoHS compliant will use '-XXXE.'

Schematic


## Package Outline Drawings

## 8-Pin DIP Package (HCPL-4562)



## 8-Pin DIP Package with Gull Wing Surface M ount Option 300 (HCPL-4562)



## 8-Pin Widebody DIP Package (HCNW 4562)



NOTE: FLOATING LEAD PROTRUSION IS 0.25 mm ( 10 mils ) MAX.

8-Pin Widebody DIP Package with Gull Wing Surface M ount Option 300 (HCNW 4562)


## Solder Reflow Temperature Profile



Note: Non-halide flux should be used.

## Recommended Pb-Free IR Profile



Note: Non-halide flux should be used.

## Regulatory Information

The devices contained in this data sheet have been approved by the following organizations:

UL
Recognized under UL 1577,
Component Recognition
Program, File E55361.
CSA
Approved under CSA
Component Acceptance Notice \#5, File CA 88324.

IEC/ EN/ DIN EN 60747-5-2
Approved under:
IEC 60747-5-2:1997 + A1:2002
EN 60747-5-2:2001 + A1:2002
DIN EN 60747-5-2 (VDE 0884
Teil 2):2003-01
(HCNW4562 only)

Insulation and Safety Related Specifications

| Parameter | Symbol | $\begin{gathered} \hline \text { 8- Pin DIP } \\ \text { (300 M il) } \\ \text { Value } \\ \hline \end{gathered}$ | Widebody ( 400 Mil ) Value | Units | Conditions |
| :---: | :---: | :---: | :---: | :---: | :---: |
| M inimum External Air Gap (External Clearance) | L(101) | 7.1 | 9.6 | mm | M easured from input terminals to output terminals, shortest distance through air. |
| M inimum External Tracking (External Creepage) | L(102) | 7.4 | 10.0 | mm | M easured from input terminals to output terminals, shortest distance path along body. |
| M inimum Internal Plastic Gap (Internal Clearance) |  | 0.08 | 1.0 | mm | Through insulation distance, conductor to conductor, usually the direct distance betw een the photoemitter and photodetector inside the optocoupler cavity. |
| M inimum Internal Tracking (Internal Creepage) |  | NA | 4.0 | mm | M easured from input terminals to output terminals, along internal cavity. |
| Tracking Resistance (Comparative <br> Tracking Index) | CTI | 200 | 200 | Volts | DIN IEC 112/ VDE 0303 Part 1 |
| Isolation Group |  | IIIa | IIIa |  | Material Group <br> (DIN VDE 0110, 1/ 89, Table 1) |

Option 300 - surface mount classification is Class A in accordance with CECC 00802.

## IEC/ EN/ DIN EN 60747-5-2 Insulation Related Characteristics (HCNW 4562 ONLY)

| Description | Symbol | Characteristic | Units |
| :---: | :---: | :---: | :---: |
| Installation classification per DIN VDE 0110/ 1.89, Table 1 for rated mains voltage $\leq 600 \mathrm{~V}$ rms for rated mains voltage $\leq 1000 \mathrm{~V}$ rms |  | I-IV |  |
|  |  | I-III |  |
| Climatic Classification |  | 55/85/21 |  |
| Pollution Degree (DIN VDE 0110/ 1.89) |  | 2 |  |
| M aximum W orking Insulation Voltage | $V_{\text {IORM }}$ | 1414 | $\mathrm{V}_{\text {peak }}$ |
| Input to Output Test Voltage, M ethod b* <br> $\mathrm{V}_{\text {IORM }} \times 1.875=\mathrm{V}_{\text {PR, }}, 100 \%$ Production Test with $\mathrm{t}_{\mathrm{m}}=1 \mathrm{sec}$, <br> Partial Discharge $<5 \mathrm{pC}$ | $V_{P R}$ | 2652 | V peak |
| Input to Output Test Voltage, M ethod a* $V_{\text {IORM }} \times 1.5=V_{\text {PR }}$, Type and sample test, $\mathrm{t}_{\mathrm{m}}=60 \mathrm{sec}$, Partial Discharge $<5 \mathrm{pC}$ | $V_{P R}$ | 2121 | V peak |
| Highest Allow able Overvoltage* (Transient Overvoltage, $\mathrm{t}_{\text {ini }}=10 \mathrm{sec}$ ) | $V_{\text {IOTM }}$ | 8000 | $V$ peak |
| Safety Limiting Values <br> (M aximum values allowed in the event of a failure, also see Figure 17, Thermal Derating curve.) <br> Case Temperature <br> Input Current <br> Output Power | $\begin{gathered} \mathrm{T}_{\mathrm{S}} \\ \mathrm{I}_{\mathrm{S}, \mathrm{NPUT}} \\ \mathrm{P}_{\mathrm{S}, \text { OUTPUT }} \end{gathered}$ | $\begin{aligned} & 150 \\ & 400 \\ & 700 \\ & \hline \end{aligned}$ | $\begin{gathered} { }^{\circ} \mathrm{C} \\ \mathrm{~mA} \\ \mathrm{~mW} \end{gathered}$ |
| Insulation Resistance at $\mathrm{T}_{5}, \mathrm{~V}_{10}=500 \mathrm{~V}$ | $\mathrm{R}_{\mathrm{S}}$ | $\geq 10^{9}$ | $\Omega$ |

*Refer to the front of the optocoupler section of the current catalog, under Product Safety Regulations section IEC/ EN/ DIN EN 60747-5-2, for a detailed description.
Note: Isolation characteristics are guaranteed only within the safety maximum ratings which must be ensured by protective circuits in application.

Absolute M aximum Ratings


Recommended Operating Conditions

| Parameter | Symbol | Device | Min. | Max. | Units | Note |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Operating Temperature | $\mathrm{T}_{\mathrm{A}}$ | HCPL-4562 | -10 | 70 | ${ }^{\circ} \mathrm{C}$ |  |
| Quiescent Input Current | $\mathrm{I}_{\mathrm{FQ}}$ | HCPL-4562 |  | 6 | mA |  |
|  |  | HCNW 4562 |  | 10 |  |  |
| Peak Input Current | $\mathrm{IF}_{\text {F(PEAK) }}$ | HCPL-4562 |  | 10 | mA |  |
|  |  | HCNW 4562 |  | 17 |  |  |

## Electrical Specifications (DC)

$\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}, \mathrm{I}_{\mathrm{F}}=6 \mathrm{~mA}$ for $\mathrm{HCPL}-4562$ and $\mathrm{I}_{\mathrm{F}}=10 \mathrm{~mA}$ for HCNW 4562 (i.e., Recommended $\mathrm{I}_{\mathrm{FQ}}$ ) unless otherwise specified.


Small Signal Characteristics (AC)
$T_{A}=25^{\circ} \mathrm{C}, \mathrm{I}_{\mathrm{F}}=6 \mathrm{~mA}$ for HCPL-4562 and $\mathrm{I}_{\mathrm{F}}=10 \mathrm{~mA}$ for HCNW4562 (i.e., Recommended $\mathrm{I}_{\mathrm{F}}$ ) unless otherwise specified.


## Package Characteristics

All Typicals at $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$

| Parameter | Sym. | Device | Min. | Typ. | Max. | Units | Test Conditions | Fig. | Note |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Input-Output | $\mathrm{V}_{\text {ISO }}$ | HCPL-4562 | 3750 |  |  | V rms | $\begin{aligned} & \text { RH } \leq 50 \%, \\ & t=1 \text { min. }^{2}, \\ & T_{A}=25^{\circ} \mathrm{C} \end{aligned}$ |  5,12 <br>   <br>  5,13 |  |
| Momentary |  | HCNW 4562 | 5000 |  |  |  |  |  |  |
| Withstand Voltage* |  | $\begin{aligned} & \text { HCPL-4562 } \\ & \text { (Option 020) } \end{aligned}$ | 5000 |  |  |  |  |  |  |
| Input-Output Resistance | $\mathrm{R}_{1-0}$ | HCPL-4562 |  | $10^{12}$ |  | $\Omega$ | $\mathrm{V}_{1.0}=500 \mathrm{Vdc}$ |  | 5 |
|  |  | HCNW 4562 | $10^{12}$ | $10^{13}$ |  |  | $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$ |  |  |
|  |  |  | $10^{11}$ |  |  |  | $\mathrm{T}_{\mathrm{A}}=100^{\circ} \mathrm{C}$ |  |  |
| Input-Output | $\mathrm{C}_{1-0}$ | HCPL-4562 |  | 0.6 |  | pF | $\mathrm{f}=1 \mathrm{MHz}$ |  | 5 |
| Capacitance |  | HCNW 4562 |  | 0.5 | 0.6 |  |  |  |  |

*The Input-Output M omentary Withstand Voltage is a dielectric voltage rating that should not be interpreted as an input-output continuous voltage rating. For the continuous voltage rating refer to the VDE 0884 Insulation Related Characteristics Table (if applicable), your equipment level safety specification or Avago Application Note 1074 entitled "Optocoupler Input-Output Endurance Voltage," publication number 5963-2203E.

## Notes:

1. When used in the circuit of Figure 1 or Figure $4 ; \mathrm{G}_{\mathrm{V}}=\mathrm{V}_{\text {OUT }} / \mathrm{V}_{\mathbb{I N}} ; \mathrm{I}_{\mathrm{FQ}}=6 \mathrm{~mA}$ (HCPL4562), $I_{\mathrm{FQ}}=10 \mathrm{~mA}$ (HCNW 4562).
2. Derate linearly above $70^{\circ} \mathrm{C}$ free-air temperature at a rate of $2.0 \mathrm{~mW} /{ }^{\circ} \mathrm{C}$ (HCPL-4562).
3. Maximum variation from the best fit line of $I_{P B}$ V. $I_{F}$ expressed as a percentage of the peak-to-peak full scale output.
4. CURRENT TRANSFER RATIO (CTR) is defined as the ratio of output collector current, $l_{0}$, to the forward LED input current, $l_{F}$, times $100 \%$.
5. Device considered a two-terminal device: Pins $1,2,3$, and 4 shorted together and Pins $5,6,7$, and 8 shorted together.
6. Flat-band, small-signal voltage gain.
7. The frequency at which the gain is 3 dB below the flat-band gain.
8. Differential gain is the change in the small-signal gain of the optocoupler at 3.58 M Hz as the bias level is varied over a given range.
9. Differential phase is the change in the small-signal phase response of the optocoupler at 3.58 M Hz as the bias level is varied over a given range.
10. TOTAL HARM ONIC DISTORTION (THD) is defined as the square root of the sum of the square of each harmonic distortion component. The THD of the isolated video circuit is measured using a $2.6 \mathrm{k} \Omega$ load in series with the $50 \Omega$ input impedance of the spectrum analyzer.
11. ISOLATION M ODE REJ ECTION RATIO (IM RR), a measure of the optocoupler's ability to reject signals or noise that may exist betw een input and output terminals, is defined by $20 \log _{10}\left[\left(\mathrm{~V}_{\text {OUT }} / \mathrm{V}_{\text {IN }}\right) /\left(\mathrm{V}_{\text {Out }} /\right.\right.$ $\left.V_{\text {IM }}\right)$ ], where $V_{\text {IM }}$ is the isolation mode voltage signal.
12. In accordance with UL 1577 , each optocoupler is proof tested by applying an insulation test voltage $\geq 4500 \mathrm{~V}$ rms for 1 second (leakage detection current limit, $\mathrm{I}_{1.0} \leq 5 \mu \mathrm{~A}$ ). This test is performed before the $100 \%$ Production test shown in the IEC/ EN/ DIN EN 60747-5-2 Insulation Related Characteristics Table, if applicable.
13. In accordance with UL 1577, each optocoupler is proof tested by applying an insulation test voltage $\geq 6000 \mathrm{~V}$ rms for 1 second (leakage detection current limit, $\left.I_{1-0} \leq 5 \mu \mathrm{~A}\right)$. This test is performed before the $100 \%$ Production test shown in the IEC/ EN/ DIN EN 60747-5-2 Insulation Related Characteristics Table, if applicable.


NOTE: ALL RESISTORS ARE 1\% TOLERANCE

Figure 1. Gain and bandwidth test circuit.


Figure 2. Base photo current test circuit.


Figure 3. Base photo current frequency response test circuit.


Figure 4. Recommended isolated video interface circuit.


Figure 5. Input current vs. forw ard voltage.


Figure 6. Base photo current vs. input current.


Figure 7. Small-signal response vs. input current.


Figure 8. Current transfer ratio vs. temperature.



Figure 9. Current transfer ratio vs. input current.



Figure 10. Base photo current variation vs. bias conditions.


Figure 11. Normalized voltage gain vs. frequency.



Figure 12. Normalized base photo current vs. frequency,


Figure 13. Phase vs. frequency.


Figure 14. Isolation mode rejection ratio vs. frequency.


Figure 15. DC output voltage vs. transistor current gain.


Figure 16. Output buffer stage for low impedance loads.


Figure 17. Thermal derating curve, dependence of safety limiting value with case temperature per IEC/ EN/ DIN EN 60747-5-2.

## Conversion from HCPL-4562 to HCNW 4562

In order to obtain similar circuit performance when converting from the HCPL-4562 to the HCNW4562, it is recommended to increase the Quiescent Input Current, $I_{\mathrm{FQ}}$, from 6 mA to 10 mA . If the application circuit in Figure 4 is used, then potentiometer R4 should be adjusted appropriately.

## Design Considerations of the Application Circuit

The application circuit in Figure 4 incorporates several features that help maximize the bandwidth performance of the HCPL-4562/HCNW4562. Most important of these features is peaked response of the detector circuit that helps extend the frequency range over which the voltage gain is relatively constant. The number of gain stages, the overall circuit topology, and the choice of DC bias points are all consequences of the desire to maximize bandwidth performance.

To use the circuit, first select $R_{1}$ to set $V_{E}$ for the desired LED quiescent current by:

$$
\begin{equation*}
I_{F Q}=\frac{V_{E}}{R_{4}} \cong G_{V} V_{E} R_{10} \tag{1}
\end{equation*}
$$

For a constant value $\mathrm{V}_{\text {INp-p }}$, the circuit topology (adjusting the gain with $\mathrm{R}_{4}$ ) preserves linearity by keeping the modulation factor (MF) dependent only on $\mathrm{V}_{\mathrm{E}}$.

$$
\begin{align*}
& \mathrm{i}_{\mathrm{F}_{\overline{\mathrm{p}}-\overline{\mathrm{p}}}} \cong \mathrm{~V}_{\mathrm{IN}} / \mathrm{R}_{4}  \tag{2}\\
& \frac{i_{F p-p}}{I_{F Q}} \cong \frac{i_{p B}^{p-p}}{I_{P B Q}}=\frac{V_{I N p-p}}{V_{E}} \tag{3}
\end{align*}
$$


For a given $\mathrm{G}_{\mathrm{V}}, \mathrm{V}_{\mathrm{E}}$, and $\mathrm{V}_{\mathrm{CC}}$, DC output voltage will vary only with $\mathrm{h}_{\text {FEx }}$.
$V_{O}=V_{C C}-V_{B_{E}}-\frac{R_{9}}{R_{10}}\left[V_{B E X}-\left(I_{\text {PBQ }}-I_{B X Q}\right) R_{7}\right]$
Where:

$$
\begin{equation*}
\mathrm{I}_{\mathrm{PBQ}} \cong \frac{\mathrm{G}_{\mathrm{v}} \mathrm{~V}_{\mathrm{E}} \mathrm{R}_{10}}{-\mathrm{R}_{7} \mathrm{R}_{9}} \tag{6}
\end{equation*}
$$

and,

$$
\begin{equation*}
\mathrm{I}_{\mathrm{BXQ}} \cong \frac{\mathrm{~V}_{\mathrm{CC}}-2 \mathrm{~V}_{\mathrm{BE}}}{\mathrm{R}_{6}-\mathrm{h}_{\mathrm{FEX}}} \tag{7}
\end{equation*}
$$

Figure 15 shows the dependency of the DC output voltage on $\mathrm{h}_{\text {fex }}$.

For $9 \mathrm{~V}<\mathrm{V}_{\mathrm{CC}}<12 \mathrm{~V}$, select the value of $\mathrm{R}_{11}$ such that

$$
\begin{equation*}
\mathrm{I}_{\mathrm{C} 44} \cong \frac{\mathrm{~V}_{0}}{\mathrm{R}_{11}} \leq \frac{4.25 \mathrm{~V}}{470-\Omega} \leq 9.0 \mathrm{~mA} \tag{8}
\end{equation*}
$$

The voltage gain of the second stage $\left(Q_{3}\right)$ is approximately equal to:

$$
\begin{array}{cc}
\mathrm{R}_{9} & *-\cdots-1  \tag{9}\\
\mathrm{R}_{10} & 1+\mathrm{s} \mathrm{R}_{9}\left[\mathrm{C}_{\mathrm{CQ}_{3}}+\frac{1}{2 \pi \mathrm{R}_{11}^{\prime} \mathrm{f}_{\mathrm{T}_{4}}}\right]
\end{array}
$$

Increasing $R_{11}^{\prime}$ ( $\mathrm{R}_{11}^{\prime}$ includes the parallel combination of $R_{11}$ and the load impedance) or reducing $R_{9}$ (keeping $R_{9} / R_{10}$ ratio constant) will improve the bandwidth.

If it is necessary to drive a low impedance load, bandwidth may also be preserved by adding an additional emitter following the buffer stage ( $\mathrm{Q}_{5}$ in Figure 16), in which case $\mathrm{R}_{11}$ can be increased to set $\mathrm{ICQ4} \cong 2 \mathrm{~mA}$.

Finally, adjust $R_{4}$ to achieve the desired voltage gain.

$$
G_{V} \cong \frac{V_{0 U T}}{V_{I N}} \cong \frac{\partial I_{P B}}{\partial I_{F}}\left[\begin{array}{c}
R_{7} R_{g}  \tag{10}\\
\frac{R_{4}}{} \mathrm{R}_{10}
\end{array}\right]
$$

where typically $\frac{\partial I_{P B}}{\partial I_{F}}=0.0032$
Definition:
$\mathrm{G}_{\mathrm{V}}=$ Voltage Gain
$I_{F Q}=$ Quiescent LED forward current
$\mathrm{i}_{\mathrm{Fp}-\mathrm{p}}=$ Peak-to-peak small signal LED forward current
$\mathrm{V}_{\text {IN } p-\mathrm{p}}=$ Peak-to-peak small signal input voltage
$\mathrm{i}_{\text {PBp-p }}=$ Peak-to-peak small signal base photo current
$I_{\text {PBQ }}=$ Quiescent base photo current
$\mathrm{V}_{\mathrm{BEX}}=$ Base-Emitter voltage of HCPL-4562/ HCNW4562 transistor
$I_{B \times Q}=$ Quiescent base current of HCPL-4562/ HCNW4562 transistor
$\mathrm{h}_{\mathrm{FEX}}=$ Current Gain ( $\mathrm{I}_{\mathrm{C}} \mathrm{I}_{\mathrm{B}}$ ) of HCPL-4562/ HCNW4562 transistor
$\mathrm{V}_{\mathrm{E}}=$ Voltage across emitter degeneration resistor $\mathrm{R}_{4}$
$\mathrm{f}_{\mathrm{T}_{4}}=$ Unity gain frequency of $\mathrm{Q}_{5}$
$\mathrm{C}_{\mathrm{CQ}_{3}}=$ Effective capacitance from collector of $\mathrm{Q}_{3}$ to ground


[^0]:    CAUTION: It is advised that normal static precautions be taken in handling and assembly of this component to prevent damage and/or degradation which may be induced by ESD.

